

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10632499	OLSCHEWSKI, FRANK
	Examiner	Art Unit
	Dennis Rosario	2624

SEARCHED

Class	Subclass	Date	Examiner
382	103	3/6/08	DR
348	169	3/6/08	DR
382	103 updated	9/2/08	DR

SEARCH NOTES

Search Notes	Date	Examiner
East, all dB	3/6/08	DR
ACM-+microscope +trajectory +vector-	3/6/08	DR
IEEE- ((((microscope)<in>metadata)<and>((track*)<in>metadata))<and>((vector)<in>metadata))-	3/6/08	DR
East, all db, updated	9/2/08	DR
IEEE-((trajector* <near/5> pixel)<in>metadata)-	9/2/08	DR

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner

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